TOSHIBA Power MOS FET Module Silicon N Channel MOS Type (Four L<sup>2</sup>-π-MOSV in One)

# **MP4411**

High Power, High Speed Switching Applications
For Printer Head Pin Driver and Pulse Motor Driver
For Solenoid Driver

- 4-V gate drivability
- Small package by full molding (SIP 12 pin)
- High drain power dissipation (4-device operation) :  $P_T = 28 \text{ W (Tc} = 25^{\circ}\text{C)}$
- Low drain-source ON resistance: RDS (ON) =  $0.28 \Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 3.5 \text{ S (typ.)}$
- Low leakage current: IGSS =  $\pm 10~\mu A$  (max) (VGS =  $\pm 16~V$ )

 $I_{DSS} = 100 \,\mu A \,(max) \,(V_{DS} = 100 \,V)$ 

• Enhancement-mode:  $V_{th} = 0.8 \text{ to } 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

### **Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	100	V	
Drain-gate voltage (R <sub>GS</sub>	= 20 kΩ)	$V_{DGR}$	100	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC	ID	3	Α	
Dialii cuiteili	Pulse	$I_{DP}$	12	A	
Drain power dissipation		D-	0.0	W	
(1-device operation, Ta =	= 25°C)	P <sub>D</sub>	2.2		
Drain power dissipation	Ta = 25°C	P <sub>DT</sub>	4.4	W	
(4-device operation)	Tc = 25°C	רטו	28	VV	
Single pulse avalanche energy (Note 1)		EAS	140	mJ	
Avalanche current		I <sub>AR</sub>	3	Α	
Repetitive avalanche energy (Note 2)	1 device operation	E <sub>AR</sub>	0.22	mJ	
	4 devices operation	E <sub>ART</sub>	0.44	IIIJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature ran	ge	T <sub>stg</sub>	−55 to 150	°C	

Note 1: Condition for avalanche energy (single pulse) measurement

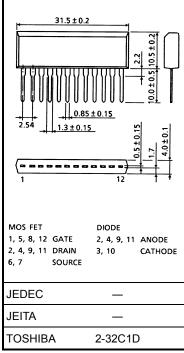
 $V_{DD}$  = 50 V, starting  $T_{Ch}$  = 25°C, L = 20 mH,  $R_{G}$  = 25  $\Omega$ ,  $I_{AR}$  = 3 A

Note 2: Repetitive rating; pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.

#### Industrial Applications

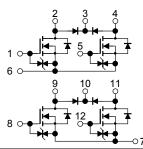
Unit: mm



Weight: 3.9 g (typ.)

Array Configuration

## **Thermal Characteristics**



Characteristics	Symbol	Max	Unit	
Thermal resistance from channel to ambient	ΣR <sub>th (ch-a)</sub>	28.4	°C/W	
(4-device operation, Ta = 25°C)				
Thermal resistance from channel to case	ΣR <sub>th (ch-c)</sub>	4.46	°C/W	
(4-device operation, Tc = 25°C)	, ,			
Maximum lead temperature for soldering purposes	TL	260	°C	
(3.2 mm from case for t = 10 s)	_			

# Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μA
Drain cut-off curr	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		_	100	μΑ
Drain-source bre	akdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	100	_	_	V
Gate threshold vo	oltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	0.8	_	2.0	V
Drain source ON	recistance	Pro (OV)	V <sub>GS</sub> = 4 V, I <sub>D</sub> = 2 A	_	0.36	0.45	Ω
Drain-source ON resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A		0.28	0.35	Ω	
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2 A	1.5	3.5	_	S
Input capacitance	e	C <sub>iss</sub>			280	_	pF
Reverse transfer	capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		50	_	pF
Output capacitance (		Coss			105	_	pF
Rise time  Turn-on time  Switching time  Fall time  Turn-off time	Rise time	t <sub>r</sub>	V <sub>GS</sub> O V OUT C SES	_	20	_	
	Turn-on time	t <sub>on</sub>		_	50	_	20
	t <sub>f</sub>	C		40	_	ns	
	Turn-off time	t <sub>off</sub>	$V_{IN}$ : $t_r$ , $t_f < 5$ ns, duty $\le 1\%$ , $t_W = 10 \ \mu s$	I	170	_	
Total gate charge (gate-source plus gate-drain)		Qg	V <sub>DD</sub> ≈ 80 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3 A	_	13.5	_	nC
Gate-source charge		$Q_{gs}$			8.5	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>	]	_	5	_	nC

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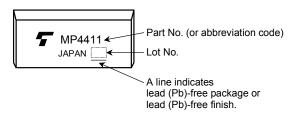
# Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current	I <sub>DR</sub>	_	_	_	3	Α
Pulse drain reverse current	I <sub>DRP</sub>	_	_	_	12	Α
Diode forward voltage	V <sub>DSF</sub>	IDR = 3 A, VGS = 0 V	_	_	-1.5	٧
Reverse recovery time	t <sub>rr</sub>	IDR = 3 A, VGS = 0 V, dIDR/dt = 50 A/µs	_	100	_	ns
Reverse recovery charge	Q <sub>rr</sub>		_	0.2	_	μC

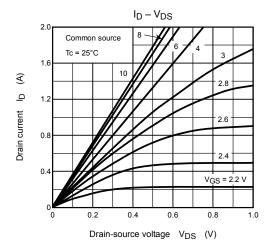
## Flyback-Diode Rating and Characteristics (Ta = 25°C)

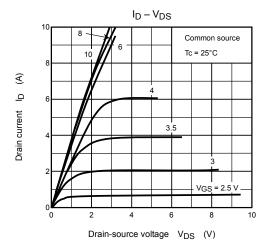
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward current	I <sub>FM</sub>	_	_	_	3	Α
Reverse current	I <sub>R</sub>	VR = 100 V	_	_	0.4	μA
Reverse voltage	V <sub>R</sub>	I <sub>R</sub> = 100 μA	100	_	_	V
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 0.5 A		_	1.8	V

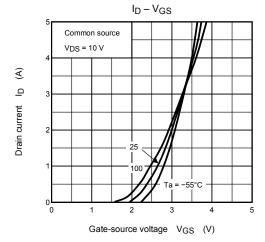
## Marking

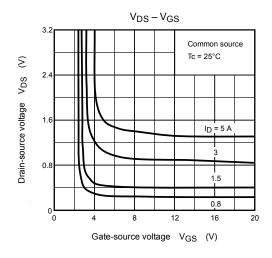


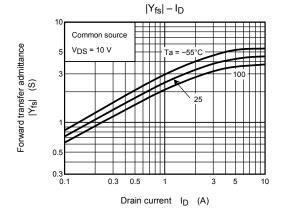
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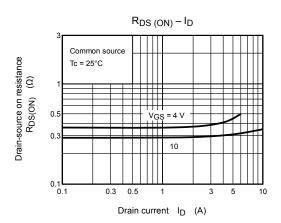


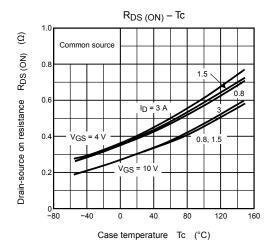


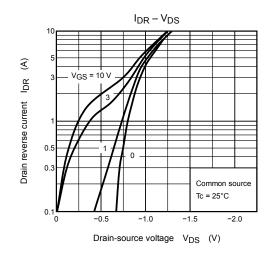


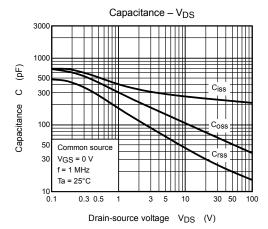


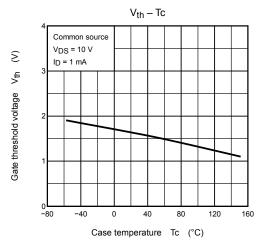


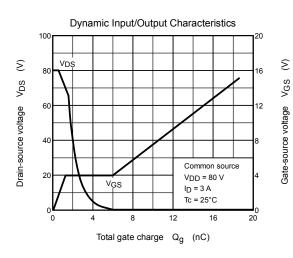


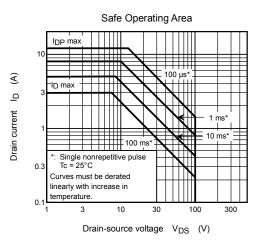




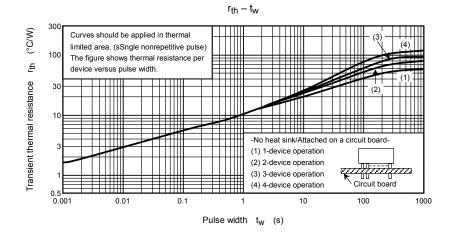


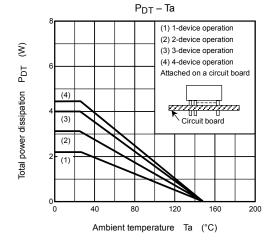


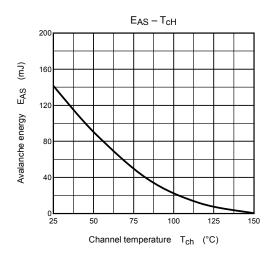


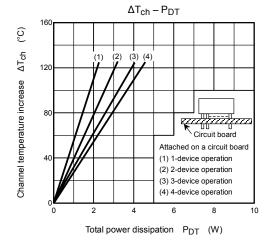


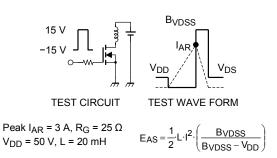
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Handbook" etc..

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